

Description

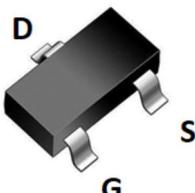
P-channel Enhancement Mode Power MOSFET

Features

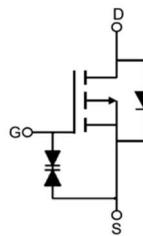
- $V_{DS} = -20V$, $I_D = -5A$
- $R_{DS(ON)} < 48m\Omega$ @ $V_{GS} = -4.5V$
- $R_{DS(ON)} < 65m\Omega$ @ $V_{GS} = -2.5V$
- Advanced Trench Technology
- Excellent $R_{DS(ON)}$ and Low Gate Charge
- Lead free product is acquired
- ESD Rating: HBM 2.0KV

Application

- PWM Applications
- Load Switch
- Power Management



SOT-23 top view



Schematic Diagram

Absolute Maximum Ratings ($T_A=25^\circ C$ unless otherwise specified)

Symbol	Parameter		Max.	Units
V_{DSS}	Drain-Source Voltage		-20	V
V_{GSS}	Gate-Source Voltage		± 8	V
I_D	Continuous Drain Current	$T_A = 25^\circ C$	-5	A
		$T_A = 70^\circ C$	-4	
I_{DM}	Pulsed Drain Current ^{note1}		-30	A
P_D	Power Dissipation	$T_A = 25^\circ C$	1.5	W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient		104	$^\circ C/W$
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	$^\circ C$

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
Off Characteristic						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D = -250\mu\text{A}$	-20	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -20\text{V}, V_{GS} = 0\text{V},$	-	-	-1	μA
I_{GSS}	Gate to Body Leakage Current	$V_{DS} = 0\text{V}, V_{GS} = \pm 8\text{V}$	-	-	± 10	uA
On Characteristics						
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$	-0.4	-0.7	-1.0	V
$R_{DS(\text{on})}$ note2	Static Drain-Source on-Resistance	$V_{GS} = -4.5\text{V}, I_D = -4\text{A}$	-	38	48	$\text{m}\Omega$
		$V_{GS} = -2.5\text{V}, I_D = -4\text{A}$	-	48	65	
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS} = -10\text{V}, V_{GS} = 0\text{V}, f = 1.0\text{MHz}$	-	950	-	pF
C_{oss}	Output Capacitance		-	165	-	pF
C_{rss}	Reverse Transfer Capacitance		-	120	-	pF
Q_g	Total Gate Charge	$V_{DS} = -10\text{V}, I_D = -4\text{A}, V_{GS} = -4.5\text{V}$	-	12	-	nC
Q_{gs}	Gate-Source Charge		-	1.4	-	nC
Q_{gd}	Gate-Drain("Miller") Charge		-	3.6	-	nC
Switching Characteristics						
$t_{d(on)}$	Turn-on Delay Time	$V_{DD} = -10\text{V}, I_D = -2\text{A}, R_G = 3\Omega, V_{GEN} = -4.5\text{V}, R_L = 2.5\Omega$	-	12	-	ns
t_r	Turn-on Rise Time		-	10	-	ns
$t_{d(off)}$	Turn-off Delay Time		-	19	-	ns
t_f	Turn-off Fall Time		-	25	-	ns
Drain-Source Diode Characteristics and Maximum Ratings						
I_s	Maximum Continuous Drain to Source Diode Forward Current	-	-	-4	A	
I_{SM}	Maximum Pulsed Drain to Source Diode Forward Current	-	-	-16	A	
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0\text{V}, I_s = -4\text{A}$	-	-	-1.2	V

Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

2. Pulse Test: Pulse Width≤300μs, Duty Cycle≤2%

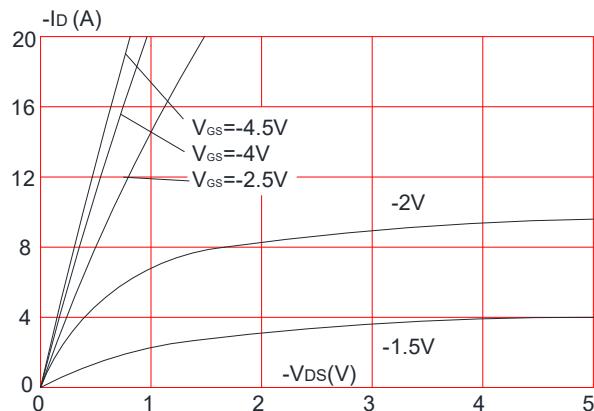
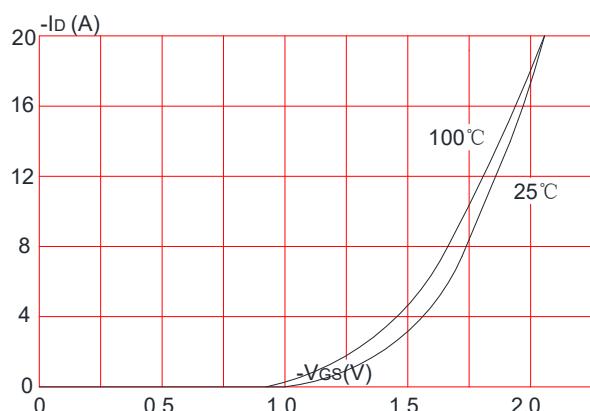
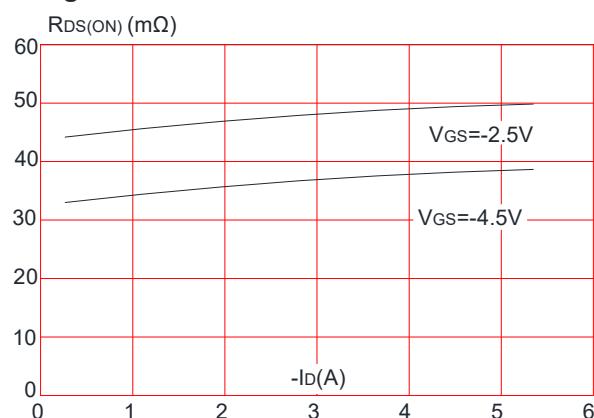
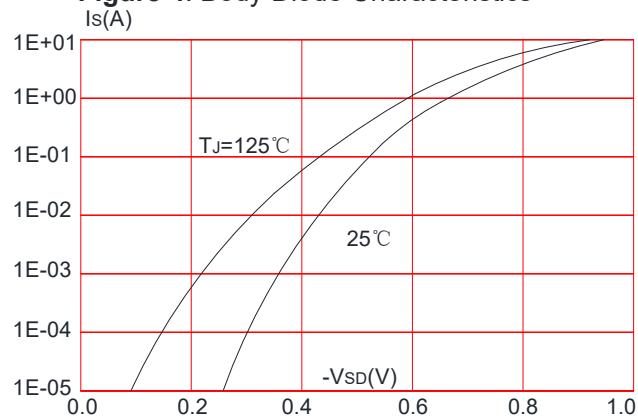
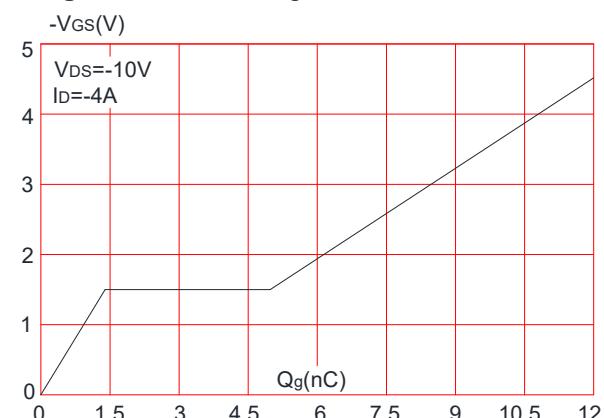
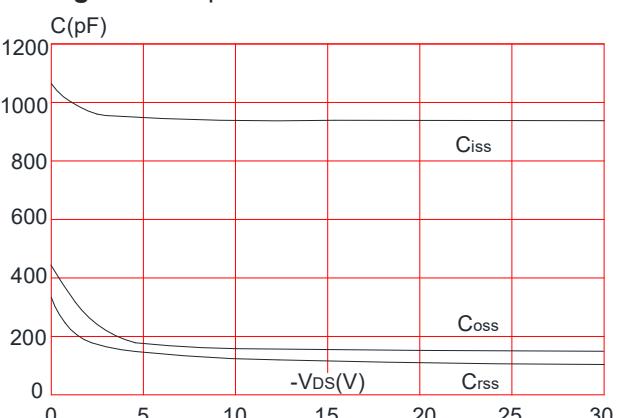
Figure1: Output Characteristics

Figure 2: Typical Transfer Characteristics

Figure 3: On-resistance vs. Drain Current

Figure 4: Body Diode Characteristics

Figure 5: Gate Charge Characteristics

Figure 6: Capacitance Characteristics


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

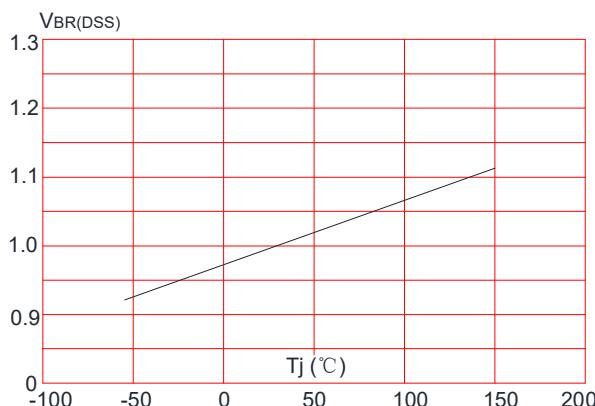


Figure 8: Normalized on Resistance vs. Junction Temperature

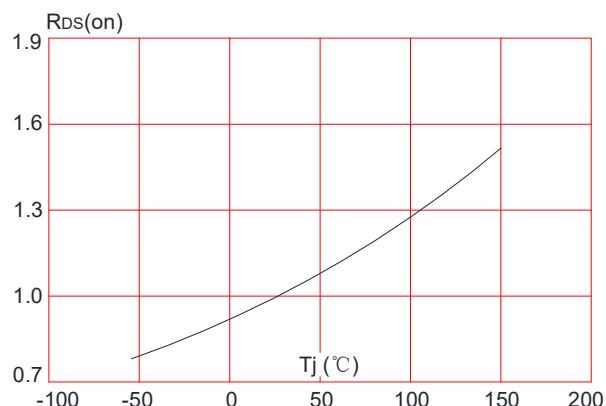


Figure 9: Maximum Safe Operating Area

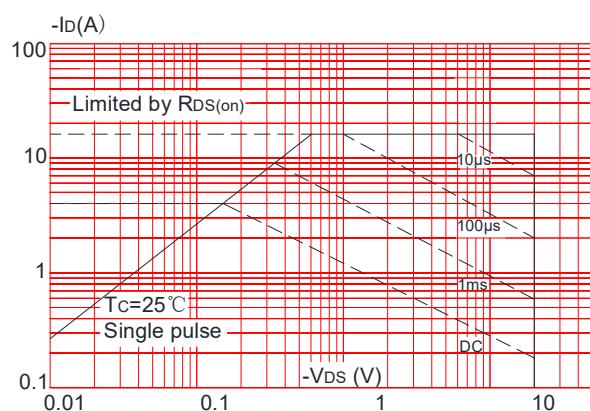


Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature

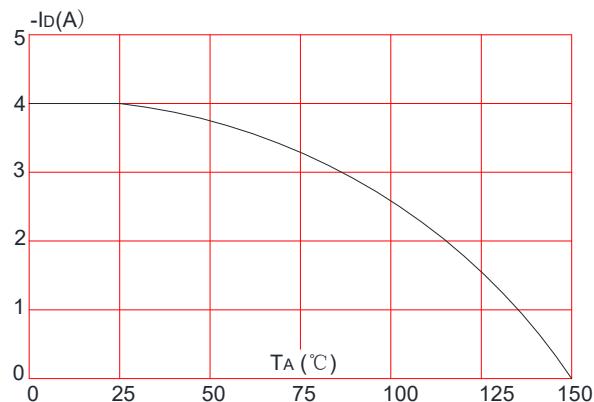
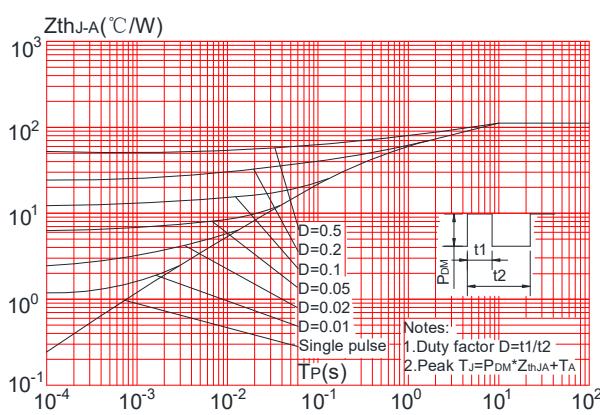
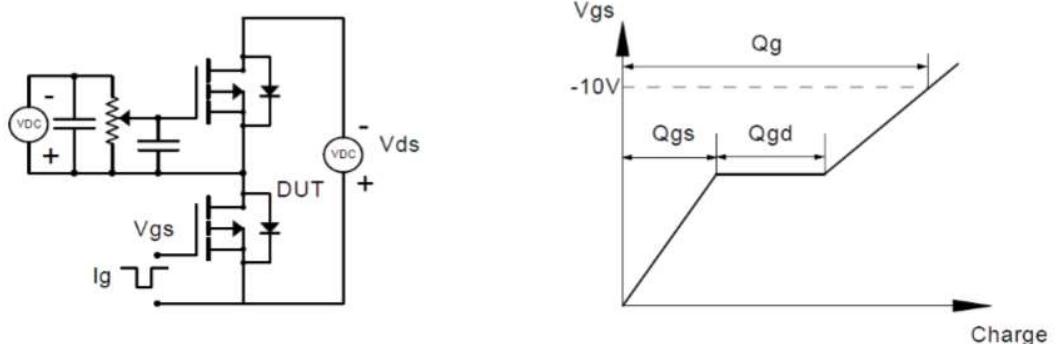


Figure 11: Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

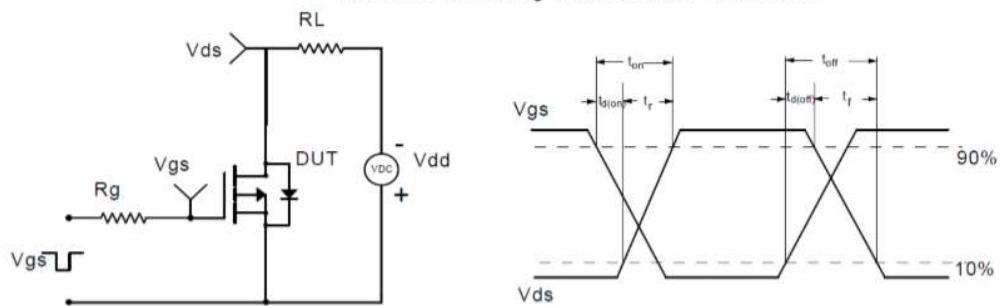


Test Circuit

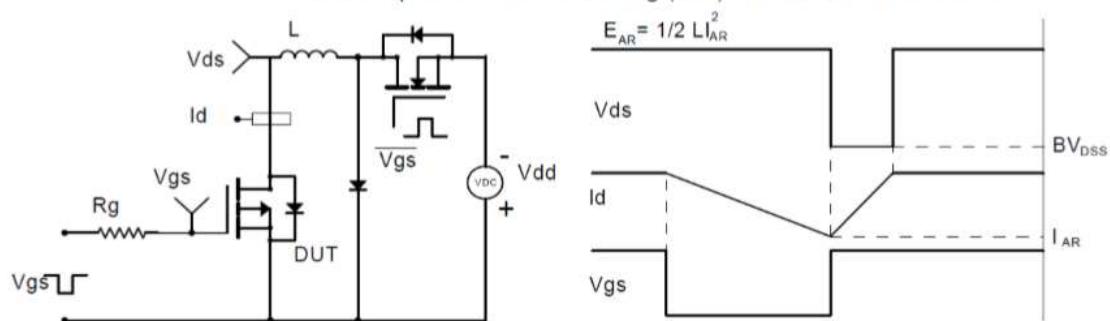
Gate Charge Test Circuit & Waveform



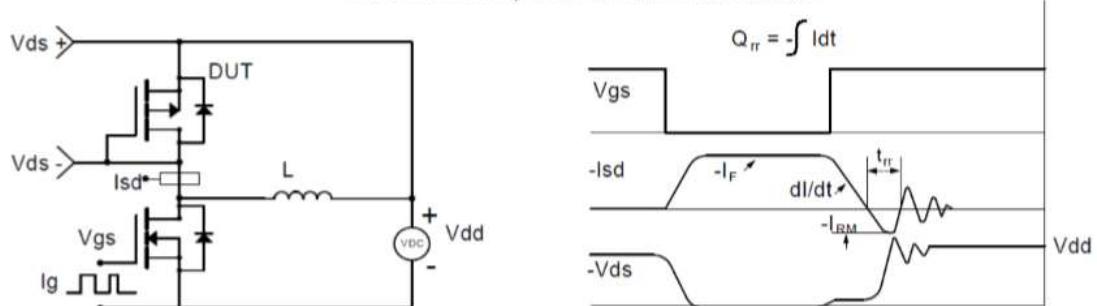
Resistive Switching Test Circuit & Waveforms



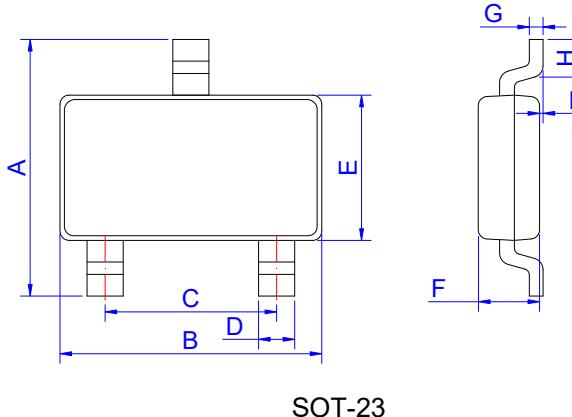
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

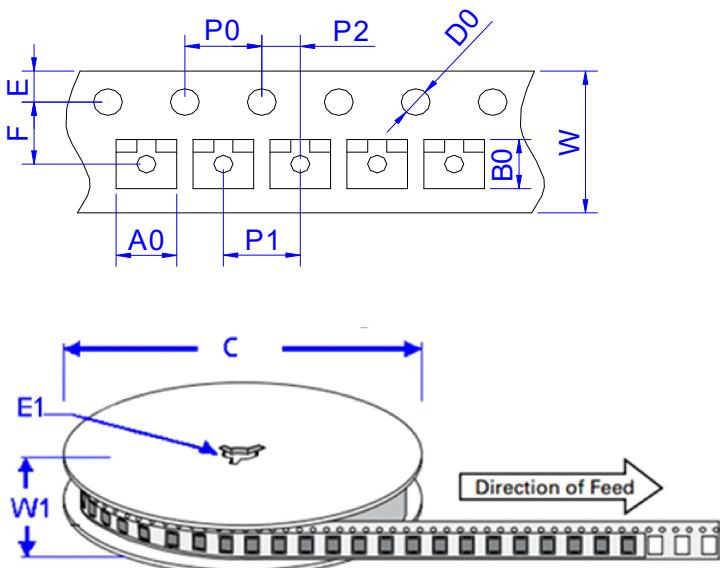


Package Mechanical Data-SOT-23



Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	2.30	2.40	2.50	0.091	0.095	0.098
B	2.80	2.90	3.00	0.110	0.114	0.118
C	1.90 REF			0.075 REF		
D	0.35	0.40	0.45	0.014	0.016	0.018
E	1.20	1.30	1.40	0.047	0.051	0.055
F	0.90	1.00	1.10	0.035	0.039	0.043
G		0.10	0.15		0.004	0.006
H	0.20			0.008		
I	0		0.10	0		0.004

Package Information-SOT-23



Ref.	Dimensions	
	Millimeters	Inches
A0	3.15 ± 0.3	0.124 ± 0.012
B0	2.77 ± 0.3	0.109 ± 0.012
C	178	7.0
D0	1.50 ± 0.1	0.059 ± 0.004
E	1.75 ± 0.2	0.069 ± 0.008
E1	13.3 ± 0.3	0.524 ± 0.012
F	3.5 ± 0.2	0.138 ± 0.008
P0	4.00 ± 0.2	0.157 ± 0.008
P1	4.00 ± 0.2	0.157 ± 0.008
P2	2.00 ± 0.2	0.079 ± 0.008
W	8.00 ± 0.2	0.315 ± 0.008
W1	11.5 ± 1.0	0.453 ± 0.039

回流焊作业参数与炉温曲线标准

Recommended Reflow Soldering Profile

Limiting Values*

The below temperature profile for moisture sensitivity characterization is based on the IPC/JEDEC joint industry standard: J-STD-020D-01.

Profile Feature	Pb-free assembly
Average ramp-up rate ($T_{s\max}$ to T_p)	3 °C/s maximum
Preheat Temperature minimum ($T_{s\min}$) Temperature maximum ($T_{s\max}$) Time ($t_{s\min}$ to $t_{s\max}$)	150 °C 200 °C 60 s to 180 s
Time maintained above Temperature (T_L) Time (t_L)	217 °C 60 s to 150 s
Peak/classification temperature (T_p)	260 °C
Number of allowed reflow cycles	3
Time within 5 °C of actual peak temperature (t_p)	20 s to 40 s
Ramp-down rate	6 °C/s maximum
Time 25 °C to peak temperature	8 minutes maximum

temperature

